

Issue Classification				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/820,494	DESAI ET AL	
Examiner				Art Unit		
A. Sefer				2826		

ORIGINAL				CROSS REFERENCE(S)											
CLASS	SUBCLASS	CLASS	SUBCLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)											
257	706	257	707												
INTERNATIONAL CLASSIFICATION				438	125										
H	0	1	L	21/48											
H	0	1	L	23/34											
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<i>Ahmed A. Sefer 6/30/04</i>				<i>NATHAN J. SIEGMUND SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2000</i>											
(Assistant Examiner) (Date)				(Primary Examiner) (Date)											
<i>Alex J. Jelonek 7/14/06</i>															
(Legal Instruments Examiner) (Date)															
Total Claims Allowed: 15															
<table border="1"> <tr> <td>O.G. Print Claim(s)</td> <td>O.G. Print Fig.</td> </tr> <tr> <td>2</td> <td>2a</td> </tr> </table>												O.G. Print Claim(s)	O.G. Print Fig.	2	2a
O.G. Print Claim(s)	O.G. Print Fig.														
2	2a														

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	2	14	31	61	91	121	151
2	3	15	32	62	92	122	152
3	4			63	93	123	153
4	5			64	94	124	154
5	6			65	95	125	155
6	7			66	96	126	156
7	8			67	97	127	157
8	9			68	98	128	158
9	10			69	99	129	159
10		40		70	100	130	160
11	11			71	101	131	161
12	12			72	102	132	162
13	13			73	103	133	163
14	12			74	104	134	164
15				75	105	135	165
16				76	106	136	166
17				77	107	137	167
18				78	108	138	168
19				79	109	139	169
20				80	110	140	170
21				81	111	141	171
22				82	112	142	172
23				83	113	143	173
24				84	114	144	174
25				85	115	145	175
26				86	116	146	176
27				87	117	147	177
28				88	118	148	178
29				89	119	149	179
13	30			90	120	150	180
							210